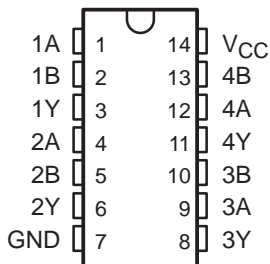


SN54AC08, SN74AC08 QUADRUPLE 2-INPUT POSITIVE-AND GATES

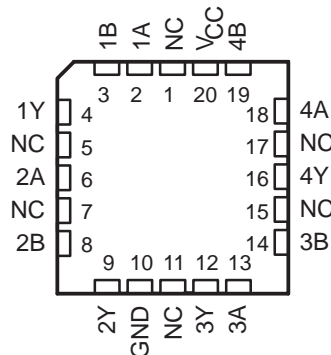
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- 2-V to 6-V V_{CC} Operation
- Inputs Accept Voltages to 6 V
- Max t_{pd} of 7.5 ns at 5 V

SN54AC08 . . . J OR W PACKAGE
SN74AC08 . . . D, DB, N, NS, OR PW PACKAGE
(TOP VIEW)



SN54AC08 . . . FK PACKAGE
(TOP VIEW)



NC – No internal connection

description/ordering information

The 'AC08 devices are quadruple 2-input positive-AND gates. These devices perform the Boolean function $Y = A \bullet B$ or $Y = \bar{A} + \bar{B}$ in positive logic.

ORDERING INFORMATION

T_A	PACKAGE†		ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	PDIP – N	Tube	SN74AC08N	SN74AC08N
	SOIC – D	Tube	SN74AC08D	AC08
		Tape and reel	SN74AC08DR	
	SOP – NS	Tape and reel	SN74AC08NSR	AC08
	SSOP – DB	Tape and reel	SN74AC08DBR	AC08
-55°C to 125°C	TSSOP – PW	Tube	SN74AC08PW	AC08
		Tape and reel	SN74AC08PWR	
-55°C to 125°C	CDIP – J	Tube	SNJ54AC08J	SNJ54AC08J
	CFP – W	Tube	SNJ54AC08W	SNJ54AC08W
	LCCC – FK	Tube	SNJ54AC08FK	SNJ54AC08FK

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

FUNCTION TABLE
(each gate)

INPUTS		OUTPUT
A	B	Y
H	H	H
L	X	L
X	L	L



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
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On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

SN54AC08, SN74AC08 QUADRUPLE 2-INPUT POSITIVE-AND GATES

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logic diagram, each gate (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC}	–0.5 V to 7 V
Input voltage range, V_I (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Output voltage range, V_O (see Note 1)	–0.5 V to $V_{CC} + 0.5$ V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$)	±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V_{CC} or GND	±200 mA
Package thermal impedance, θ_{JA} (see Note 2):	
D package	86°C/W
DB package	96°C/W
N package	80°C/W
NS package	76°C/W
PW package	113°C/W
Storage temperature range, T_{stg}	–65°C to 150°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 3)

		SN54AC08		SN74AC08		UNIT
		MIN	MAX	MIN	MAX	
V_{CC}	Supply voltage	2	6	2	6	V
V_{IH}	High-level input voltage	$V_{CC} = 3$ V		2.1		V
		$V_{CC} = 4.5$ V		3.15		
		$V_{CC} = 5.5$ V		3.85		
V_{IL}	Low-level input voltage	$V_{CC} = 3$ V		0.9		V
		$V_{CC} = 4.5$ V		1.35		
		$V_{CC} = 5.5$ V		1.65		
V_I	Input voltage	0	V_{CC}	0	V_{CC}	V
V_O	Output voltage	0	V_{CC}	0	V_{CC}	V
I_{OH}	High-level output current	$V_{CC} = 3$ V		–12		mA
		$V_{CC} = 4.5$ V		–24		
		$V_{CC} = 5.5$ V		–24		
I_{OL}	Low-level output current	$V_{CC} = 3$ V		12		mA
		$V_{CC} = 4.5$ V		24		
		$V_{CC} = 5.5$ V		24		
$\Delta t/\Delta v$	Input transition rise or fall rate	8		8		ns/V
T_A	Operating free-air temperature	–55	125	–40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

